

Diode Datasheet Example : 1N4007

<https://www.onsemi.com/pdf/datasheet/1n4001-d.pdf>

1N4001, 1N4002, 1N4003, 1N4004, 1N4005, 1N4006, 1N4007

Electrical Parameters.

MAXIMUM RATINGS

Rating	Symbol	1N4001	1N4002	1N4003	1N4004	1N4005	1N4006	1N4007	Unit
†Peak Repetitive Reverse Voltage Working Peak Reverse Voltage DC Blocking Voltage	V_{RRM} V_{RWM} V_R	50	100	200	400	600	800	1000	V
†Non-Repetitive Peak Reverse Voltage (halfwave, single phase, 60 Hz)	V_{RSM}	60	120	240	480	720	1000	1200	V
†RMS Reverse Voltage	$V_{R(RMS)}$	35	70	140	280	420	560	700	V
†Average Rectified Forward Current (single phase, resistive load, 60 Hz, $T_A = 75^\circ\text{C}$)	I_O	1.0							A
†Non-Repetitive Peak Surge Current (surge applied at rated load conditions)	I_{FSM}	30 (for 1 cycle)							A
Operating and Storage Junction Temperature Range	T_J T_{stg}	-65 to +150							$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

†Indicates JEDEC Registered Data.

Thermal Parameters.

THEMAL CHARACTERISTICS

Rating	Symbol	Max	Unit
Maximum Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	Note 1	$^\circ\text{C/W}$

NPTEL

$$T_J = T_A + (R_{\theta JA} \times P_D)$$

T_A : Ambient
 P_D : Power Dissipation
 $R_{\theta JA}$:

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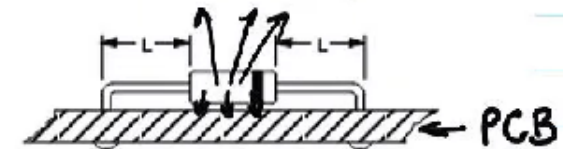
Electrical Parameters.

Thermal Parameters.

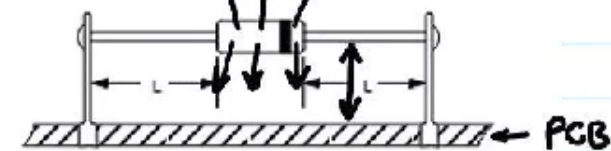
TYPICAL VALUES FOR $R_{\theta JA}$ IN STILL AIR

Mounting Method ✓	$R_{\theta JA}$	Lead Length, L			Units
		1/8	1/4	1/2	
1	$R_{\theta JA}$	52	65	72	$^\circ\text{C/W}$
2		67	80	87	$^\circ\text{C/W}$
3		50			$^\circ\text{C/W}$

MOUNTING METHOD 1

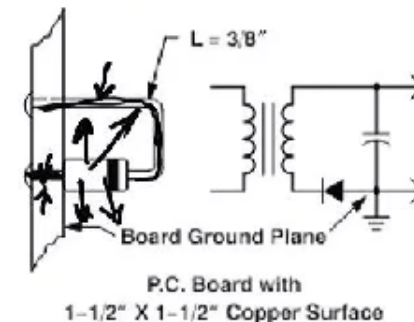


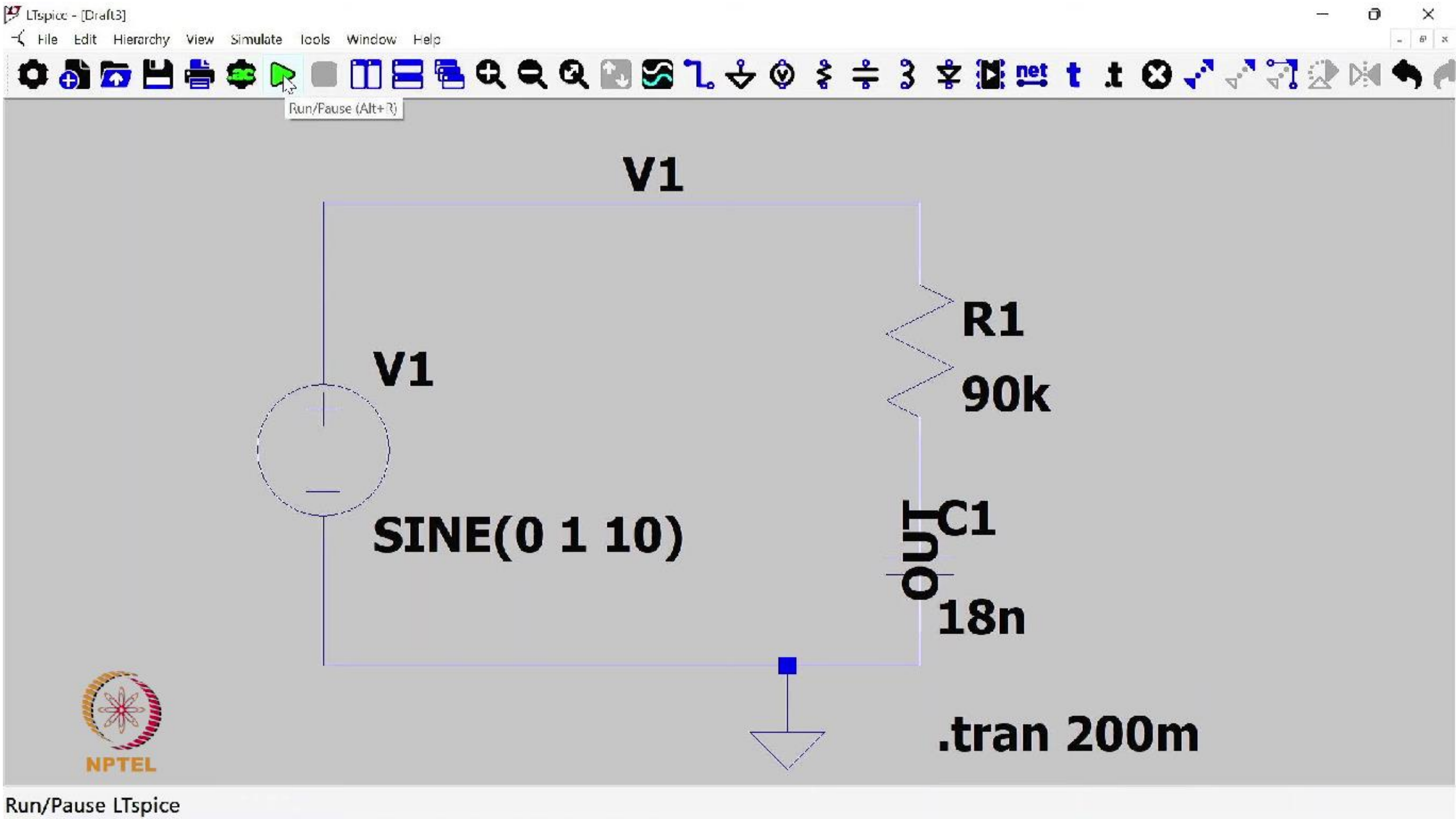
MOUNTING METHOD 2

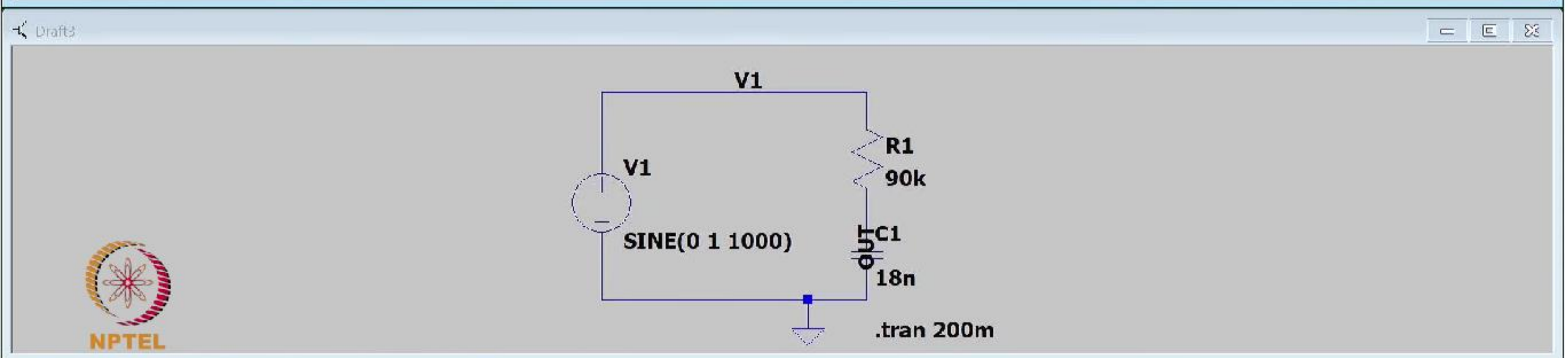
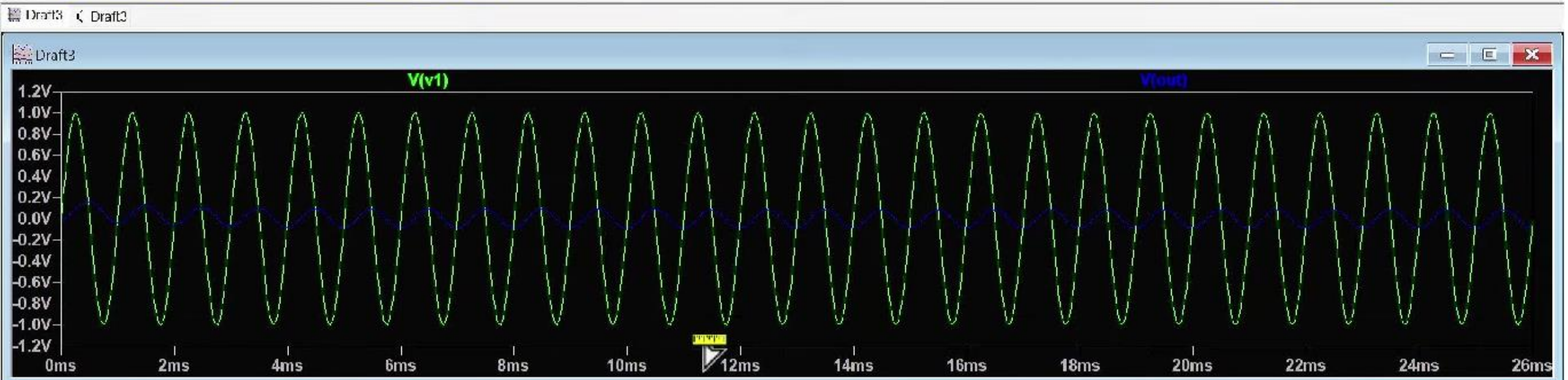


Vector Pin Mounting

MOUNTING METHOD 3







Frequency Domain Simulations :

- So far, we worked on time-domain analysis and dc analysis.

Now let's enter the frequency domain.

→ Frequency domain analysis

The frequency domain refers to the analysis of mathematical functions or signals with respect to frequency.

→ Small-signal analysis

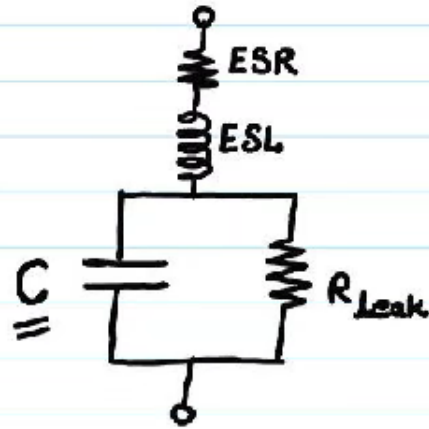
Linearization of circuit characteristics at certain dc bias point with small magnitude of variables.

→ AC analysis

AC means alternative-current signals in frequency domain



Real Capacitor Circuit model :

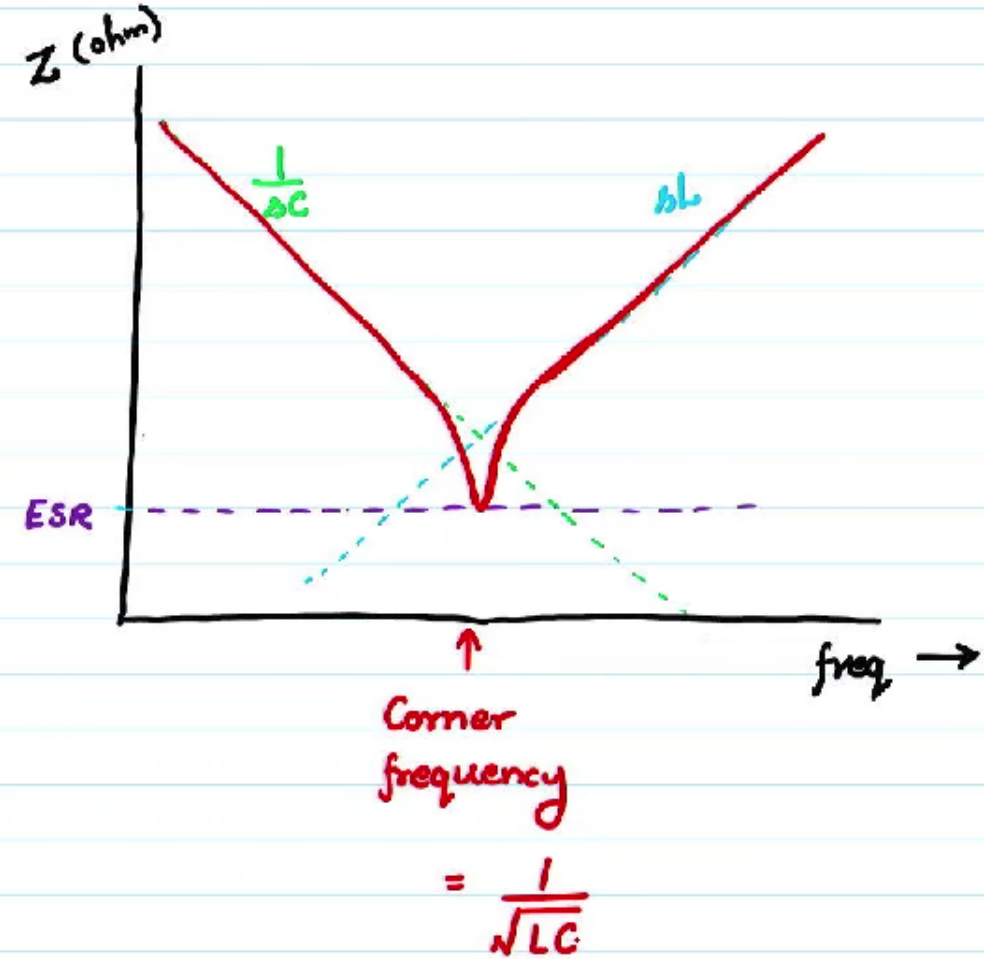


$$Z = Z_C \parallel Z_{R_{leak}} + Z_{ESL} + ESR$$

$$\approx \frac{1}{sC} + sL + ESR$$

A red curved arrow points from the $\frac{1}{sC}$ term to the sL term, indicating the resonance condition where their magnitudes are equal.

at $\omega = \omega_0$



Fast Fourier Transform :

To exit full screen, press Esc

it computes the discrete
Fourier Transform of a sequence.